

**INFORMATION DISCLOSURE
CITATION**

Atty. Docket No.: D-43378-01

Serial No.: 09/657,679

Applicants: Joe Milton Bowen, Marc Alan Edlein, and Ram K. Ramesh

Filing Date: September 8, 2000

Group: *

U.S. PATENT DOCUMENTS

Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date If Appropriate
<i>Em</i>	1.	H304	07/07/87	Vorrier et al	522	92	
	2.	RE. 35,203	04/09/96	Wakalopulos	250	492.3	
	3.	3,850,675	11/26/74	Miller	117	93.31	
	4.	3,933,407	01/20/76	Tu et al	350	61	
	5.	3,936,557	02/03/76	Watt	428	211	
	6.	3,978,260	08/31/76	Dobbins et al	428	204	
	7.	4,064,296	12/20/77	Bornstein et al	428	35	
	8.	4,070,497	01/24/78	Wismer et al	427	44	
	9.	4,197,344	04/08/80	Tshudy	428	212	
	10.	4,309,452	01/05/82	Sachs	427	44	
	11.	4,410,560	10/18/83	Kosterka	427	44	
	12.	4,439,480	03/27/84	Sachs et al	428	161	
	13.	4,647,475	03/03/87	Inukai et al	427	44	
	14.	4,842,906	06/27/89	Ekdahl et al	428	34.2	
	15.	5,070,121	12/03/91	Hinterwaldner et al	524	31	
	16.	5,084,344	01/28/92	Harada et al	428	334	
	17.	5,330,799	07/19/94	Sandor et al	427	510	
	18.	5,379,697	01/10/95	Ertl	101	424.1	
	19.	B1 5,407,708	04/08/97	Lovin et al	427	493	
	20.	5,407,708	04/18/95	Lovin et al	427	493	
	21.	5,451,460	09/19/95	Lu et al	428	349	
	22.	5,562,951	10/08/96	Kamen	427	493	
	23.	5,645,639	07/08/97	Doesburg et al	118	60	
	24.	5,744,248	04/28/98	Meixner et al	428	482	
	25.	5,763,048	06/09/98	Takahashi	428	147	
<i>Em</i>	26.	5,945,183	08/31/99	Johnson	428	34.9	

FOREIGN PATENT DOCUMENTS

		Document Number	Date	Country	Class	Sub-Class	Translation	
							Yes	No
<i>Em</i>	1.	0 089 629 A3	09/28/83	EPO				
<i>Em</i>	2.	0 544 052 B1	06/02/93	EPO				

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3.	2 284 787-A	06/21/95	UK			
4.	57-059968	04/10/82	JP			X
5.	57-157785	09/29/82	JP			X
6.	9-302264	11/25/97	JP			X
7.	98/51437	11/19/98	PCT			
8.	WO 99/00250	01/07/99	PCT			

OTHER DOCUMENTS (Including Authors, Title, Date, Pertinent Papers, etc.)

1.	McIntyre, "UV-Cured Durable Top Coats: A Replacement for OPP & PET Film Laminations," Presented at Future-Pak 1997, October 28-29, 1997 (together with MCTC-2138 & 2139 Data Sheets)
2.	Davis et al, "Chemistry Considerations for Low-Voltage EB Applications," RadTech Report, pp. 18-20, September/October 1996.
3.	Dionne, "Can the energy-curing industry cash in on food-packaging opportunities?" Converting Magazine's Flex-Pack Management, , Vol. 4, No. 1, pp. 2-3 (January 1, 1998).
4.	Dionne, "UV/EB Curing stakes a claim on flexo-printed food packaging" Converting Magazine's Flex-Pack Management, p. 3 (February 1, 1998).
5.	Clinkunbroomer, "Though the Future is Bright for UV Inks, Wide Web Flexo Market Remains Elusive," American Ink Maker, pp. 23-26 (Sept. 1998).
6.	Harris, "UV Coating - beyond stick and shine," FlexoTech, pp. 21-22 (June 1998).
7.	Burkart, "Product Trend Report: UV Inks and Curing," Flexo, pgs. 46-49 (Sept. 1997).
8.	Pierce & Stevens Corp., Miracure EB Curable Coatings, Product Brochure, "Formulated for Success: Coatings & Adhesives for Packaging and Graphic Arts" (November 1998).
9.	Northwest Coatings Corp., "Adhesives and Coatings that Exceed our Customers' Expectations," Product Brochures and Product Sheets.
10.	Lauppi et al, "Advantages of Low Voltage Electron Beam Processing (80 kV - 110 kV)," Europe '99 RadTech Conference Proceedings, Berlin, Germany, pp. 357-366 (November 8-10, 1999).
11.	Mcintyre, "'Total Package Concept:' Electron Beam Technology for Barrier, Adhesive, and Overcoat Applications," Presented at Future-Pak '95 (20 pages) (Sept. 13-15, 1995).
12.	Wakalopoulos, "Low Voltage or Ultra Low Voltage? . . .," RADTECH REPORT, pp. 10-15 (July/August 1998).
13.	Fletcher, "New Lower-Voltage EB Systems for Curing Polymers and Coatings," Journal of Coatings Technology, Vol. 65, No. 822, pgs. 61-63 (July 1993).
14.	Leach et al, <u>The Printing Ink Manual</u> , Chapter 11, pp. 636-677 (Fifth Ed., Kluwer Academic Publishers 1993).

EXAMINER

Date Considered

*Examiner: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.